

Search Notes

Application/Control No.

10/607,195

Examiner

Shin-Hon Chen

Applicant(s)/Patent under
Reexamination

SPIES ET AL.

Art Unit

2131

SEARCHED

Class	Subclass	Date	Examiner
713	200	4/19/2005	S.C.
713	156, 175	4/19/2005	S.C.
380	277-279	4/19/2005	S.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/19/2005	S.C.